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Application/Control No.

10/621,739 Examiner

Truc T. T. Nguyen

Applicant(s)/Patent under Reexamination

WEISS ET AL.

Art Unit

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SEARCHED			
Class	Subclass	Date	Examiner
439	497 580-581 66 86	1/25/2007	TN

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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